



HiRel RadHard Power-MOS

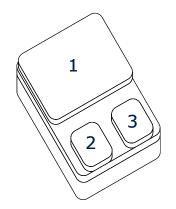
- Low R_{DS(on)}
- Single Event Effect (SEE) hardened

 $\begin{array}{ll} \text{LET 62, Range: 73} \mu\text{m (Xe)} & \text{LET 95, Range: 86} \mu\text{m (Pb)} \\ V_{GS} = -15 \text{V}, \ V_{DS} = 60 \text{V} & V_{GS} = -5 \text{V}, \ \ V_{DS} = 60 \text{V} \\ V_{GS} = -20 \text{V}, \ V_{DS} = 40 \text{V} & V_{GS} = -10 \text{V}, \ V_{DS} = 50 \text{V} \\ \end{array}$

Data Sheet

 $V_{GS} = -20V, V_{DS} = 40V$ $V_{GS} = -10V, V_{GS} = -10V, V_{G$

- Total Ionisation Dose (TID) hardened 100 kRad approved (Level R)
- Hermetically sealed
- N-channel



Туре	Marking	Pin Configuration			Package	
		1	2	3	-	
BUY06CS80A-01	-	D	G	S	-	SMD2

Maximum Ratings

Parameter	Symbol	Values	Unit
Drain Source Voltage	V _{DS}	60	V
Gate Source Voltage	V _{GS}	+/- 20	V
Drain Gate Voltage	V_{DG}	60	V
Continuous Drain Current $T_C = 25 ^{\circ}\text{C}$ $T_C = 100 ^{\circ}\text{C}$	I _D	80 ¹⁾ 60 ¹⁾	A
Continuous Source Current	Is	80	А
Drain Current Pulsed, t _p limited by T _{jmax}	I _{DM}	300	Apk
Total Power Dissipation 2)	P _{tot}	250	W
Operating and Storage Temperature	T _{op}	-55 to + 150	°C
Avalanche Energy	E _{AS}	1000	mJ

Thermal Characteristics

Thermal Resistance (Junction to Case)	R _{th JC}	0.5	K/W
Soldering Temperature	T _{sol}	250	°C

Notes.:

¹⁾ Limited by package.

²⁾ For $T_S \le 25^{\circ}$ C. For $T_S > 25^{\circ}$ C derating is required.



Data Sheet

BUY06CS80A-01

Electrical Characteristics, at T _A =25°C; unless otherwise specified					
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Breakdown Voltage Drain to Source $I_D = 0.25$ mA, $V_{GS} = 0$ V	BV _{DSS}	60	-	-	V
Temperature Coefficient of B _{VDSS}	$\Delta BV_{DSS}/\Delta T_{J}$	-	0.08	-	V/°C
Gate Threshold Voltage I _D = 1.0mA, V _{DS} ≥ V _{GS}	V _{GS(th)}	2.0	-	4.0	V
Gate to Source Leakage Current V _{DS} = 0V, V _{GS} = +/- 20V	I _{GSS}	-	-	+/-100	nA
Drain Current $V_{DS} = 48V$, $V_{GS} = 0V$	I _{DSS}	-	-	25	μΑ
Drain Source On Resistance $^{1)}$ $V_{GS} = 10V$, $I_D = 60A$	R _{DS(ON)}	-	5.6	6.5	mΩ
Source Drain Diode, Forward Voltage $^{1), 2)}$ $V_{GS} = 0V$, $I_S = 80A$	V _{SD}	-	-	1.2	V
AC Characteristics					
Turn-on Delay Time $V_{DD} = 50\% V_{DS}$, $I_D = 60A$, $R_G = 4.7\Omega$	t _{d(ON)}	-	39	46	ns
Rise Time $V_{DD} = 50\% V_{DS}$, $I_D = 60A$, $R_G = 4.7\Omega$	t _r	-	50	65	ns
Turn-off Delay Time $V_{DD} = 50\% V_{DS}$, $I_D = 60A$, $R_G = 4.7\Omega$	t _{d(OFF)}	-	85	100	ns
Fall Time $V_{DD} = 50\% V_{DS}$, $I_D = 60A$, $R_G = 4.7\Omega$	t _f	-	55	70	ns
Reverse Recovery Time $V_{DD} \le 50 \text{ V}, I_D = 80 \text{A}$	t _{rr}	-	305	340	ns
Common Source Input Capacitance V _{DS} = 40V, V _{GS} = 0V, f = 1.0MHz	C _{iss}	9.0	11.0	14.0	nF
Common Source Output Capacitance $V_{DS} = 40V$, $V_{GS} = 0V$, $f = 1.0MHz$	C _{oss}	2500	3400	4500	pF
Common Source Reverse Transfer Capacitance V _{DS} = 40V, V _{GS} = 0V, f = 1.0MHz	C _{rss}	500	600	700	pF
Gate Resistance	R_G		0.75		Ω
Total Gate Charge $V_{DD} = 50\% V_{DS}, V_{GS} = 10V, I_D = 80A$	Q_{G}	-	175	200	nC

Notes.:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.
2) Measured within 2.0 mm of case.

Data Sheet

BUY06CS80A-01

Electrical Characteristics

at T_A=125°C; unless otherwise specified

Parameter	Symbol	Values		Unit		
		min.	max.			
DC Characteristics						
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	$V_{GS(th)}$	1.5	-	V		
Gate to Source Leakage Current $V_{DS} = 0V$, $V_{GS} = +/-20V$	I_{GSS}	-	+/-200	nA		
Drain Current $V_{DS} = 48V$, $V_{GS} = 0V$	I _{DSS}	-	250	μΑ		
Drain Source On Resistance $^{1)}$ $V_{GS} = 10V$, $I_D = 60A$	r _{DS(on)}	-	10	mΩ		

Electrical Characteristics

at T_A=-55°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage I _D = 1.0mA, V _{DS} ≥ V _{GS}	$V_{GS(th)}$	-	5.0	V	

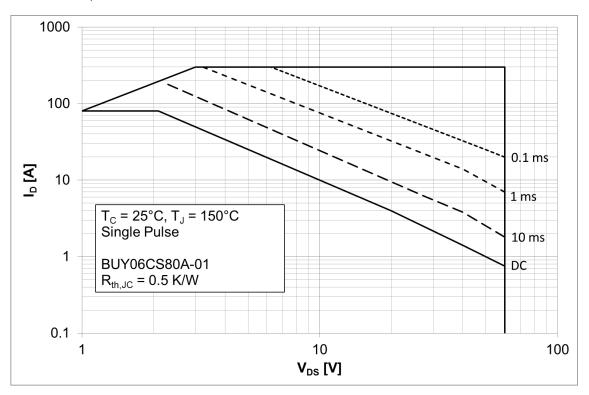
Notes.:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.



1 Safe operating area

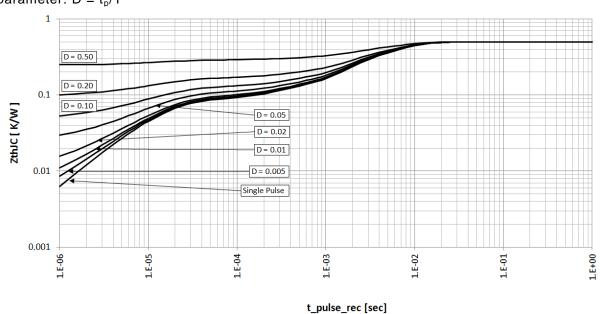
 $I_D = f(V_{DS}); T_C = 25^{\circ}C$

parameter: t_p



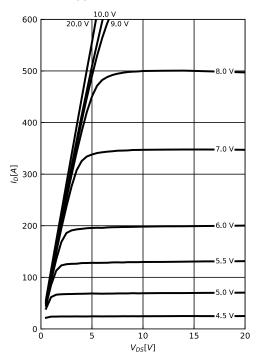
2 Max. transient thermal impedance

 $Z_{thJC} = f(t_p)$ parameter: $D = t_p/T$



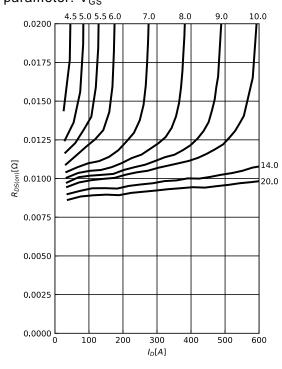
3 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$ parameter: V_{GS}



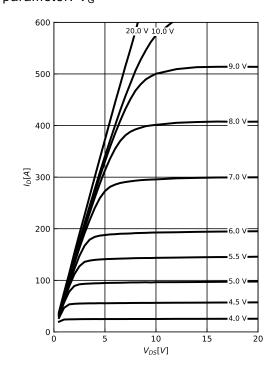
5 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 150 \text{ °C}$ parameter: V_{GS}



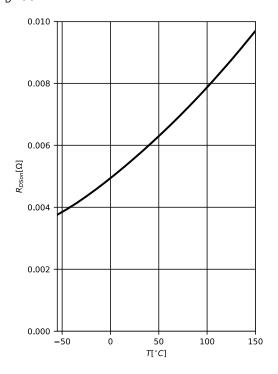
4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150 \, ^{\circ}C$ parameter: V_G



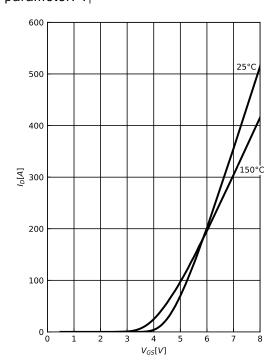
6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j)$ $I_D = 60A$



7 Typ. transfer characteristics

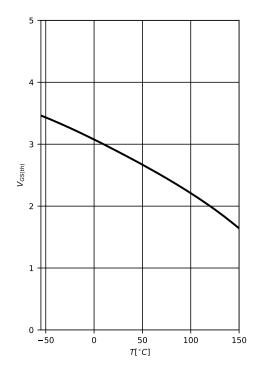
$$I_D = f(V_{GS}); V_{DS} = 20 \text{ V}$$
 parameter: T_i



8 Typ. gate threshold voltage

$$I_D = f(T_j)$$

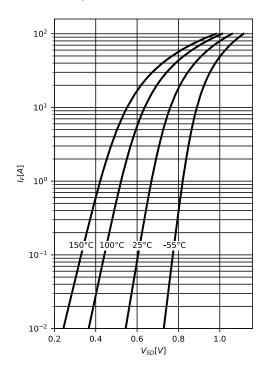
 $I_D = 1 \text{mA}$



9 Typ. forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

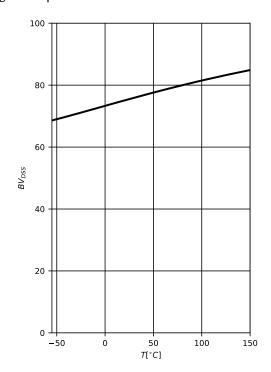
parameter: T_i



10 Typ. drain-source breakdown voltage

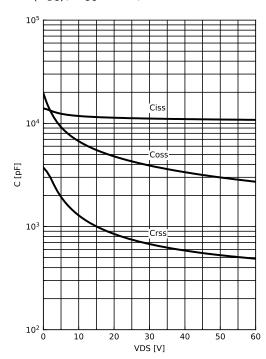
$$BV_{DSS} = f(T_j)$$

 $I_D = 250\mu A$



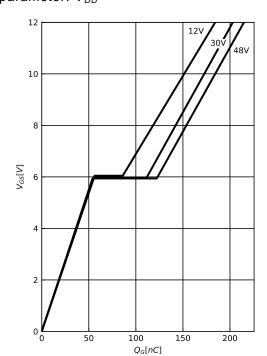
11 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$



12 Typ. gate charge

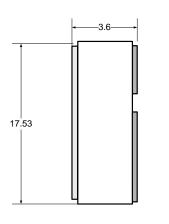
$$V_{GS} = f(Q_{gate}); I_D = 80 A pulsed parameter: V_{DD}$$

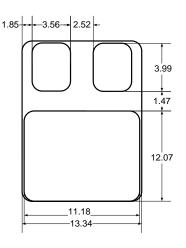


Data Sheet

BUY06CS80A-01

SMD2 Package





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Dimensions are typical [mm]

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